

SDM3055

Digital Multimeter

DataSheet-2017.06



SDM3055

Product Overview

The SDM3055 is a digital multimeter designed with 5 ½ digits readings resolution and dual-display, especially fitting to the needs of high-precision, multifunction and automatic measurement.

Application fields

- Research Laboratory
- Development Laboratory
- Repair and Maintenance
- Calibration Laboratory
- Automatic Production Test
- General bench-top use

User-Friendly Design

- 4.3" TFT-LCD, 480*272 display
- Support dual-display, Chinese and English Menu
- Built-in front panel accessible help system
- File management (support for U-disc and local storage)

Math Function

Basic Measurement Function

- DC Voltage: 200 mV ~ 1000 V
- DC Current: 200 μ A ~ 10 A
- AC Voltage: True-RMS, 200 mV ~ 750 V
- AC Current: True-RMS, 20 mA ~ 10 A
- 2/4-Wire Resistance: 200 Ω ~ 100 M Ω
- Capacitance: 2 nF ~ 10000 μ F
- Continuity Test: Range is fixed at 2 k Ω
- Diode Test: Adjustable range is 0 ~ 4V
- Frequency Measurement: 20 Hz ~ 1 MHz
- Period Measurement: 1 μ s ~ 0.05 s
- Temperature: Support for TC and RTD sensor

Math Function

- Max, Min, Average, Standard Deviation, dBm/dB, Relative Measurement, Pass/Fail Histogram, TrendChart

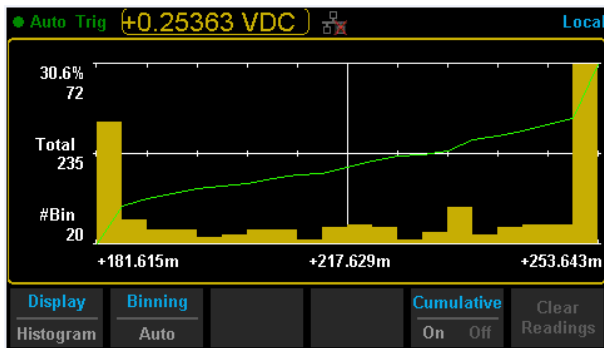
Main Feature

- Real 5½ digits readings resolution (240, 000 counts)
- Up to 150 rdgs/s measurement speed
- True-RMS AC Voltage and AC Current measuring
- 1 Gb Nand flash size, Mass storage configuration files and data files
- Built-in cold terminal compensation for thermocouple
- With easy, convenient and flexible PC software: EasyDMM
- Standard interface: USB Device, USB Host, LAN
- Optional Accessories: GPIB (only for SDM3055A) and Scanner Card
- Supports remote control via commands and compatible with commands of main stream multimeters

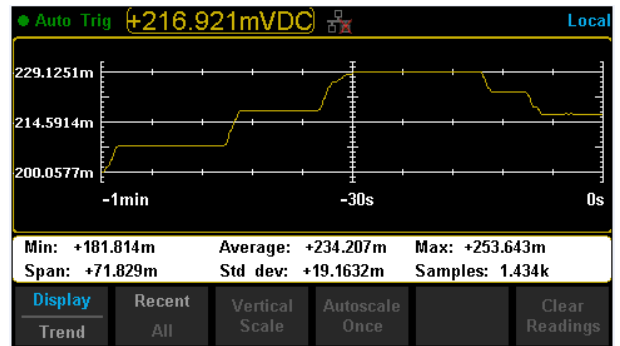


Special Features

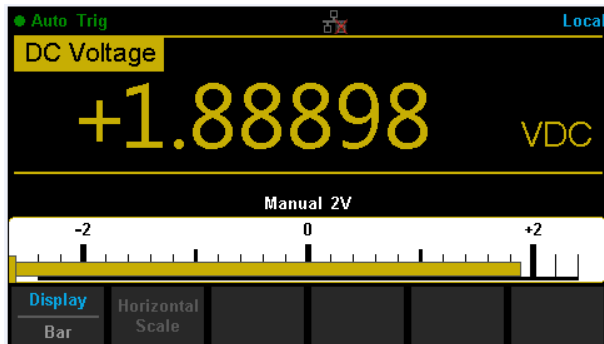
Histogram



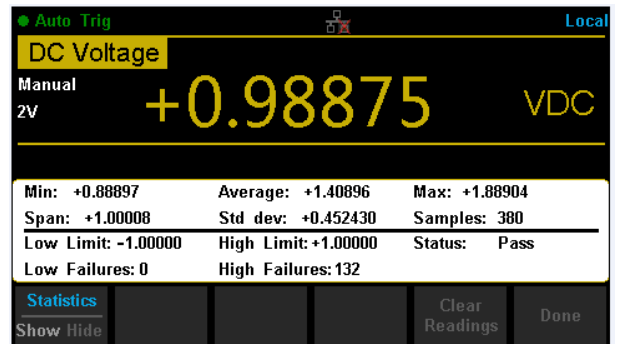
Trend Chart



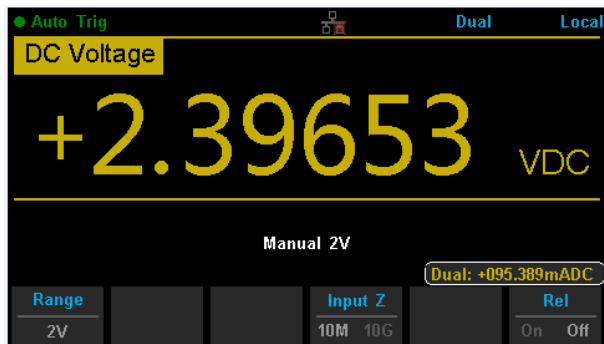
Bar Chart



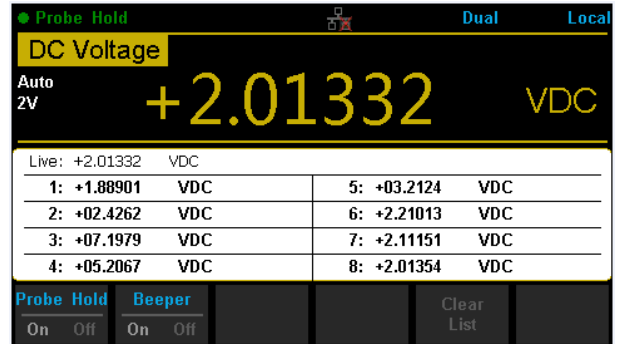
Statistics



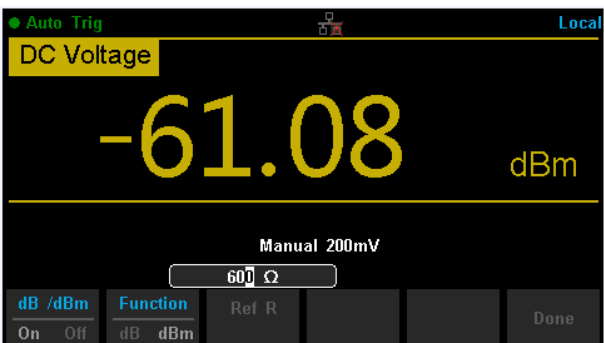
Double Display



Hold Measurement



dBm Hold Measurement



Interface



Specifications

DC Characteristic

Accuracy $\pm$ (% of Reading + % of Range)^[1]

Function	Range ^[2]	Test current or Load voltage	1Year 23°C $\pm$ 5°C	Temperature coefficient 0°C ~ 18°C 28°C ~ 50°C
DC Voltage	200 mV		0.015+ 0.004	0.0015+ 0.0005
	2 V		0.015+ 0.003	0.0010+ 0.0005
	20 V		0.015+ 0.004	0.0020+ 0.0005
	200 V		0.015+ 0.003	0.0015+ 0.0005
	1000 V ^[4]		0.015+ 0.003	0.0015+ 0.0005
DC Current	200 μ A	< 8 mV	0.055+ 0.005	0.003+ 0.001
	2 mA	< 80 mV	0.055+ 0.005	0.002+ 0.001
	20 mA	< 0.05 V	0.095+ 0.020	0.008+ 0.001
	200 mA	< 0.5 V	0.070+ 0.008	0.005+ 0.001
	2 A	< 0.1 V	0.170+ 0.020	0.013+ 0.001
	10 A ^[5]	< 0.3 V	0.250+ 0.010	0.008+ 0.001
Resistance ^[3]	200 Ω	1 mA	0.030+ 0.005	0.0030+ 0.0006
	2 K Ω	1 mA	0.020+ 0.003	0.0030+ 0.0005
	20 K Ω	100 μ A	0.020+ 0.003	0.0030+ 0.0005
	200 K Ω	10 μ A	0.020+ 0.010	0.0030+ 0.0005
	2 M Ω	1 μ A	0.040+ 0.004	0.0040+ 0.0005
	10 M Ω	200 nA	0.250+ 0.003	0.0100+ 0.0005
	100 M Ω	200 nA 10 M Ω	1.75+ 0.004	0.2000+ 0.0005
Diode Test	2.0 V ^[6]	1 mA	0.05+ 0.01	0.0050+ 0.0005
	4V	100 μ A	0.05+ 0.01	0.0050+ 0.0005
Continuity Test	2000 Ω	1 mA	0.05+ 0.01	0.0050+ 0.0005

Remarks:

[1] Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18°C ~ 28°C .

[2] 20% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A.

[3] Specifications are for 4-wire measure or 2-wire measure under "REF" operation. $\pm 0.2 \Omega$ of extra errors will be generated if perform 2-wire measure without "REF" operation.

[4] Plus 0.02 mV of error per 1 V after the first ± 500 VDC.

[5] 30 seconds OFF after 30 seconds ON is recommend for the continuous current that higher than DC 7 A or AC RMS 7 A.

[6] Accuracy specifications are only for voltage measuring at input terminal. The typical value of current under measure is 1 mA. Voltage drop at diode junction may vary with current supply.

AC CharacteristicAccuracy± (% of Reading + % of Range)^[1]

Function	Range ^[2]	Frequency Range	1Year 23°C ±5°C	Temperature coefficient 0°C ~ 18°C 28°C ~ 50°C
True-RMS AC Voltage ^[3]	200 mV	20 Hz – 45 Hz	1.5 + 0.10	0.01 + 0.005
		45 Hz – 20 KHz	0.2 + 0.05	0.01 + 0.005
		20 KHz – 50 KHz	1.0 + 0.05	0.01 + 0.005
		50 KHz – 100 KHz	3.0 + 0.05	0.05 + 0.010
	2 V	20 Hz – 45 Hz	1.5 + 0.10	0.01 + 0.005
		45 Hz – 20 KHz	0.2 + 0.05	0.01 + 0.005
		20 KHz – 50 KHz	1.0 + 0.05	0.01 + 0.005
		50 KHz – 100 KHz	3.0 + 0.05	0.05 + 0.010
	20 V	20 Hz – 45 Hz	1.5 + 0.10	0.01 + 0.005
		45 Hz – 20 KHz	0.2 + 0.05	0.01 + 0.005
		20 KHz – 50 KHz	1.0 + 0.05	0.01 + 0.005
		50 KHz – 100 KHz	3.0 + 0.05	0.05 + 0.010
	200 V	20 Hz – 45 Hz	1.5 + 0.10	0.01 + 0.005
		45 Hz – 20 KHz	0.2 + 0.05	0.01 + 0.005
		20 KHz – 50 KHz	1.0 + 0.05	0.01 + 0.005
		50 KHz – 100 KHz	3.0 + 0.05	0.05 + 0.010
	750 V	20 Hz – 45 Hz	1.5 + 0.10	0.01 + 0.005
		45 Hz – 20 KHz	0.2 + 0.05	0.01 + 0.005
		20 KHz – 50 KHz	1.0 + 0.05	0.01 + 0.005
		50 KHz – 100 KHz	3.0 + 0.05	0.05 + 0.010
True-RMS AC Current ^[4]	20 mA	20 Hz – 45 Hz	1.5 + 0.10	0.015 + 0.015
		45 Hz – 2 KHz	0.50 + 0.10	0.015 + 0.006
		2 KHz – 10 KHz	2.50 + 0.20	0.015 + 0.006
	200 mA	20 Hz – 45 Hz	1.5 + 0.10	0.015 + 0.005
		45 Hz – 2 KHz	0.50 + 0.10	0.015 + 0.005
		2 KHz – 10 KHz	2.50 + 0.20	0.015 + 0.005
	2 A	20 Hz – 45 Hz	1.5 + 0.20	0.015 + 0.005
		45 Hz – 2 KHz	0.50 + 0.20	0.015 + 0.005
		2 KHz – 10 KHz	2.50 + 0.20	0.015 + 0.005
	10 A ^[5]	20 Hz – 45 Hz	1.5 + 0.15	0.015 + 0.005
		45 Hz – 2 KHz	0.50 + 0.15	0.015 + 0.005
		2 KHz – 10 KHz	2.50 + 0.20	0.015 + 0.005

Additional wave crest factor error (not Sine) ^[6]

Wave crest coefficient	Error (% Range)
1-2	0.05
2-3	0.2

Remarks:

[1] Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18°C ~28°C .

[2] 20% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A.

[3] Specifications are for amplitude of sine wave input > 5% of range. For inputs from 1% to 5% of range and <50 kHz, add 0.1% of range extra error. For 50 kHz to 100 kHz, add 0.1% of range extra error.

[4] Specifications are for sine wave input > 5% of range. 0.1% errors will be added when the range of input sine wave is 1% to 5% .

[5] 30 seconds OFF after 30 seconds ON is recommend for the continuous current that higher than DC 7 A or AC RMS 7 A.



Frequency and Period CharacteristicAccuracy± (% of Reading + % of Range)^[1]

Function	Range	Frequency Range	1 Year 23°C ±5°C	Temperature coefficient 0°C ~ 18°C 28°C ~ 50°C
Frequency /Period	200 mV ~750 V ^[2]	20 Hz – 2 KHz	0.01+0.003	0.002+0.001
		2 KHz – 20 KHz	0.01+0.003	0.002+0.001
		20 KHz – 200 KHz	0.01+0.003	0.002+0.001
		200 KHz –1 MHz	0.01+0.006	0.002+0.002

Remarks:

[1] Specifications are for 0.5 Hour warm-up.

[2] Except for special marks, the AC input voltage is 15% to 120% of range when <100 kHz and 30% to 120% of range when >100 kHz. 750 V range is limited to 750 Vrms. The accuracy is 10 times % of reading when the measurement range of AC voltage is in 200 mV range

Capacitance CharacteristicAccuracy± (% of Reading + % of Range)^[1]

Function	Range ^[2]	Max Testing Current	1 Year 23°C ±5°C	Temperature coefficient 0°C ~ 18°C 28°C ~ 50°C
Capacitance	2 nF	200 nA	3+1.0	0.08+0.002
	20 nF	200 nA	1+0.5	0.02+0.001
	200 nF	2 µA	1+0.5	0.02+0.001
	2 µF	10 µA	1+0.5	0.02+0.001
	200 µF	100 µA	1+0.5	0.02+0.001
	10000 µF	1 mA	2+0.5	0.02+0.001

Remarks:

[1] Specifications are for 0.5 Hour warm-up and "REF" operation. Using of non-film capacitor may generate additional errors.

[2] Specifications are for from 1% to 120% on 2 nF range and ranges from 10% to 120% on other ranges.

Temperature CharacteristicAccuracy± (% of Reading + % of Range)^[1]

Function	Probe Type	Probe Model	Working Temperature Range	1Year 23°C ±5°C	Temperature coefficient 0°C ~18°C 28°C ~50°C
Temperature	RTD ^[2]	α=0.00385	-200°C ~ 660°C	0.16°C	0.08+0.002
	TC ^[3]	B	0°C ~ 1820°C	0.76 °C	0.14°C
		E	-270°C ~ 1000°C	0.5°C	0.02°C
		J	-210°C ~ 1200°C	0.5°C	0.02°C
		K	-270°C ~ 1372°C	0.5°C	0.03°C
		N	-270°C ~ 1300°C	0.5°C	0.04°C
		R	-270°C ~ 1768°C	0.5°C	0.09°C
		S	-270°C ~ 1768°C	0.6°C	0.11°C
		T	-270°C ~ 400°C	0.5°C	0.03°C

Remarks:

[1] Specifications are for 0.5 Hour warm-up, not include probe error.

[2] Specifications are for 4-wire measure or 2-wire measure under "REF" operation.

[3] Built-in cold terminal compensation for thermocouple, accuracy is ±1°C .

Measuring Method and other Characteristics

DC Voltage		
Input Resistance	200 mV and 2 V Range	10 MΩ or >10 GΩ selectable
	20 V, 200 V and 1000 V Range	10 MΩ ± 2%
Input Bias Current	<90 pA, 25°C	
Input Protection	1000 V on all ranges	
CMRR	120 dB (For the 1 KΩ unbalanced resistance in LO lead, max ±500 VDC)	
NMRR	60 dB at “slow” measurement rate	
	20 dB are added if open the “AC” filter.	
Resistance		
Testing Method	4-wire resistance or 2-wire resistance selectable	
Input Protection	1000 V on all ranges	
DC Current		
Shunt Resistor	200 μA sampling voltage < 8 mV	
	2 mA sampling voltage < 8 mV	
	1 Ω for 20 mA, 200 mA 1 Ω	
	0.01 Ω for 2 A, 10 A	
Input Protection	Rear panel : accessible 10 A,250 V fast-melt fuse Internal :12 A,250 V slow-melt fuse	
Continuity/Diode Test		
Measurement Method	1 mA ±5% constant-current source or open-circuit voltage	
Beeper	yes	
Continuity Threshold	Adjustable	
Input Protection	1000 V	
True-RMS AC Voltage		
Measurement Method	AC Coupled true RMS measure – up to 1000 V DC bias are permitted on every range.	
Wave Crest Factor	≤3 at full scale	
Input Impedance	1 MΩ ± 2% in parallel with <100 pF on all ranges	
AC Filter Bandwidth	20 Hz ~ 100 KHz	
CMRR	60 dB (For the 1 KΩ imbalance resistance among Lo lead and <60 Hz, Max ±500 VDC)	
True-RMS AC Current		
Measurement Method	DC Coupled to the fuse and shunt; AC Coupled the True-RMS measurement (measures the AC components only)	
Wave Crest Factor	≤3 at full scale	
Max Input	<10 A (include DC component)	
Shunt Resistor	1 Ω for 20 mA, 200 mA 1 Ω; 0.01 Ω for 2 A, 10 A	
Input Protection	Rear panel : accessible 10 A,250 V fast-melt fuse Internal :12 A,250 V slow-melt fuse	
Frequency/Period		
Measurement Method	Reciprocal-counting technique, AC Coupled input, AC voltage or AC current measurement function	
Measure Attentions	Error are leaded into all frequency counters when measuring low voltage or loe frequency signal.	

Capacitance Measuring

Measurement Method	Measure the rate of change of voltage generated during the current flowing the capacitance	
Connection Type	2-wire	
Input Protection	1000 V on all ranges	

Temperature Measuring

Measurement Method	Support for TC and RTD types of sensor	
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Trigger and Memory

Samples/Trigger	1~10000	
Trigger Delay	6 ms~10000 ms optional	
External Trigger Input	Input Level	TTL compatible (High level when left input terminal is hanging in the air)
	Trigger Condition	Rising and Falling selectable
	Input Impedance	$\geq 20\text{ K}\Omega//400\text{ pF}$, DC-coupled
	Min Pulse	500 μs
VMC	Level	TTL compatible
	Output Polarity	Straight and negative optional
	Output Impedance	200 Ω , typical

History Records

Volatile Memory	10 K reading of history records	
Nonvolatile Memory	1 Gb Nand Flash, Mass storage configuration files and data files, Support U-disk external storage	

Math Functions

Min/Max/Average, dBm, dB, Pass/Fail, Relative, Standard deviation, Hold, histogram, Trend chart, Bar chart

General Specifications

Power Supply	
AC 100 V ~ 120 V	50/60 Hz
AC 200 V ~ 240 V	50/60 Hz
Consumption	20 VA max
Mechanism	
Dimension	282 mm×260 mm×105 mm
Weight	3.33 Kg
Other Characteristics	
Display Screen	4.3" TFT-LCD with resolution 480*272
Operation Environment	Full accuracy from 0℃ to 50℃ , 80% RH and 40℃ , non condensing
	Storage Temperature: -20℃ -70℃
	Shock and Vibration: conforming to MIL-T-28800E, 5 level (only for sine)
	Height above sea level: up to 3000 meters
Safety	Conforming to IEC61010-1:2001. Measure CAT I 1000 V/CAT II 600V Class of pollution: 2
Remote Interface	USB-GPIB(only for SDM3055A), 10/100 Mbit LAN , USB2.0 Full Speed Device&Host
Programmer Language	Standard SCPI, compatible with commands of main stream multimeters
Warm Up Time	30 minutes

Purchase Information

Product Name	SIGLENT SDM3055/SDM3055A Digital Multimeter	
Models	SDM3055	SDM3055A
Standard Accessories	A Power Cord that fits the standard of destination country	
	Two Test Leads, Two Alligator Clips	
	A USB To GPIB Adapter (Only for SDM3055A)	
	A USB Cable	
	A Quick Start	
	A Guaranty Card	
	EasyDMM computer software system	
Optional Accessories	GPIB adapter	
	SC1016	

SDM3055

Digital Multimeter



About SIGLENT

SIGLENT is an international high-tech company, concentrating on R&D, sales, production and services of electronic test & measurement instruments.

SIGLENT first began developing digital oscilloscopes independently in 2002. After more than a decade of continuous development, SIGLENT has extended its product line to include digital oscilloscopes, function/arbitrary waveform generators, digital multimeters, DC power supplies, spectrum analyzers, isolated handheld oscilloscopes and other general purpose test instrumentation. Since its first oscilloscope, the ADS7000 series, was launched in 2005, SIGLENT has become the fastest growing manufacturer of digital oscilloscopes. We firmly believe that today SIGLENT is the best value in electronic test & measurement.

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